

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants : Anthony Jenkins  
William J. McGann  
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Appl. No. : --

Filed : Concurrently herewith

For : PORTAL TRACE DETECTION SYSTEMS FOR DETECTION OF  
IMBEDDED PARTICLES

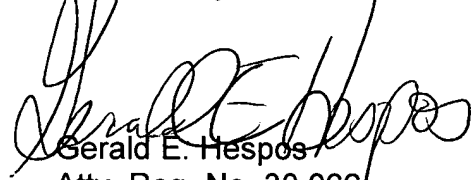
MS Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Sir:

This Information Disclosure Statement includes a copy of Form PTO-1449 that identifies several U.S. patents. These patents were cited during the prosecution of the parent application and relate generally to ion mobility spectrometers and/or security devices that employ ion mobility spectrometers. The Examiner is requested to consider these references during the examination and to make the references of record.

Respectfully submitted,



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# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Docket Number (Optional)

IT-9-Div

Application Number

Divisional of 10/033,874

Applicant(s)

Anthony Jenkins et al.

Filing Date

Concurrently herewith

Group Art Unit

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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,109,691	5-1992	Corrigan et al.			
		5,491,337	2-1996	Jenkins et al.			
		5,585,575	12-1996	Corrigan et al.			
		5,915,268	6-1999	Linker et al.			
		6,073,499	6-2000	Settles			
		6,334,365	1-2002	Linker et al.			
		6,375,697	4-2002	Davies			
		2003/0085348	5-2003	Megerle			

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER	DATE CONSIDERED
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.